## Second Phase (BaGeO<sub>3</sub>, BaSiO<sub>3</sub>) Nanocolumns in YBa<sub>2</sub>Cu<sub>3</sub>O<sub>7-x</sub> Films

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*Abstract* - YBa<sub>2</sub>Cu<sub>3</sub>O<sub>7-x</sub> (YBCO) films with BaGeO<sub>3</sub> (BGeO), BaSiO<sub>3</sub> (BSiO) second phase additions were processed by pulsed laser deposition. Sectored targets with BGO or BSiO wedges as well as pre-mixed targets of YBCO, BGeO or BSiO with appropriate compositions were used to deposit YBCO+BGeO and YBCO+BSiO films on (100) single crystal LaAlO<sub>3</sub> substrates. The cross-sectional transmission electron micrographs showed the presence of 20 nm diameter nanocolumns in the YBCO films of both the compositions. However, the critical transition temperature ( $T_c$ ) of the films was found to significantly decrease. As a result, the critical current density ( $J_c$ ) in applied magnetic fields was suppressed. The YBCO+BGeO and YBCO+BSiO films made with lower concentrations of additions showed slight improvement in  $T_c$  indicating that the substitution of Ge and Si in the lattice is possibly responsible for the  $T_c$  depression. This study shows that in addition to the ability to form nanocolumns, the chemical compatibility of BaSnO<sub>3</sub> (BSO) and BaZrO<sub>3</sub> (BZO) as observed in YBCO+BSO and YBCO+BZO is critical to process high  $J_c$  YBCO films

*Keywords* - Flux pinning, BaSnO3, BaGeO3, BaSiO3, YBa2Cu3O7-x, coated conductors, pulsed laser deposition

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